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ESD Protection Exceeds JESD 22

OEAB 1

LEAB 2

GND 4

A1 3

A2 5

A3 6

A4 8

A5 9

A6 10

A7 12

A8 🛛 13

A9 **1**14

A10 15

A11 [ 16

A12 17

GND 18

A13 19

A14 120

A15 21

V<sub>CC</sub> 22

A16 23

A17 24

GND 25

A18 26

OEBA 27

LEBA 🛛 28

GND 11

V<sub>CC</sub> [] 7

2000-V Human-Body Model (A114-A)
200-V Machine Model (A115-A)

- 1000-V Charged-Device Model (C101)

DGG PACKAGE

(TOP VIEW)

56 🛛 GND

54 🛛 B1

52 **B** B2

51 🛛 B3

48 B5

47 🛛 B6

45 🛛 B7

44 🛛 B8

42 B10

41 🛛 B11

40 B12

39 🛛 GND

38 🛛 B13

37 B14

36 B15

35 V<sub>CC</sub>

33 🛛 B17

32 GND

31 **B**18

29 GND

30 CLKBA

34 🛛 B16

B9

43

46 GND

49 B4

50 🛛 V<sub>CC</sub>

53 GND

55 CLKAB

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- Controlled Baseline
   One Assembly/Test Site, One Fabrication Site
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree<sup>†</sup>
- Member of the Texas Instruments Widebus™ Family
- UBT<sup>™</sup> Transceivers Combine D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Mode
- Supports Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V<sub>CC</sub>)
- Supports Unregulated Battery Operation Down To 2.7 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
   <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- I<sub>off</sub> and Power-Up 3-State Support Hot Insertion
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Distributed V<sub>CC</sub> and GND Pins Minimize High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JESD 17

<sup>†</sup> Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

#### description/ordering information

The SN74LVTH16500 is an 18-bit universal bus transceiver designed for low-voltage (3.3-V)  $V_{CC}$  operation, but with the capability to provide a TTL interface to a 5-V system environment.



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#### description/ordering information (continued)

#### **ORDERING INFORMATION**

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	TSSOP – DGG	Tape and reel	CLVTH16500IDGGREP	LH16500EP

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the high-to-low transition of CLKAB. OEAB is active high. When OEAB is high, the B-port outputs are active. When OEAB is low, the B-port outputs are in the high-impedance state.

Data flow for B to A is similar to that of A to B, but uses OEBA, LEBA, and CLKBA. The output enables are complementary (OEAB is active high and OEBA is active low).

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

When V<sub>CC</sub> is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

This device is fully specified for hot-insertion applications using Ioff and power-up 3-state. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

T UNUTION TABLE:								
	INPUTS							
OEAB	LEAB	CLKAB	Α	В				
L	Х	Х	Х	Z				
н	Н	Х	L	L				
н	Н	Х	Н	н				
н	L	$\downarrow$	L	L				
н	L	$\downarrow$	Н	н				
н	L	Н	Х	в <sub>0</sub> ‡ в <sub>0</sub> §				
н	L	L	Х	в <sub>0</sub> §				

#### FUNCTION TABLET

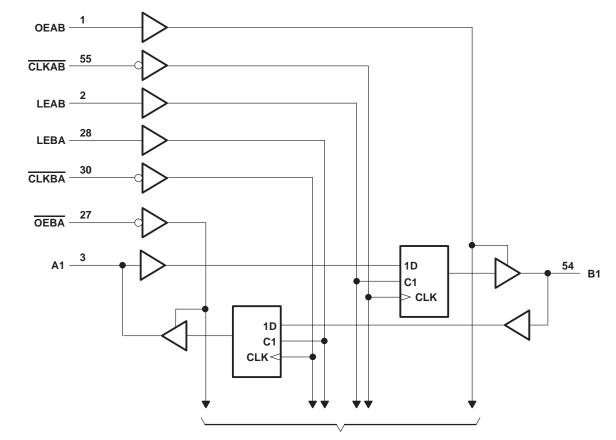
<sup>†</sup>A-to-B data flow is shown: B-to-A flow is similar, but uses OEBA, LEBA, and CLKBA.

<sup>‡</sup>Output level before the indicated steady-state input conditions were established

§ Output level before the indicated steady-state input conditions were established, provided that CLKAB was low before LEAB went low



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logic diagram (positive logic)

To 17 Other Channels

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high-impedance or power-off state, V <sub>O</sub> (see Note 1)	-0.5 V to 7 V
Voltage range applied to any output in the high state, $V_O$ (see Note 1)	
Current into any output in the low state, I <sub>O</sub>	128 mA
Current into any output in the high state, I <sub>O</sub> (see Note 2)	64 mA
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, $I_{OK}$ ( $V_O < 0$ )	
Package thermal impedance, θ <sub>JA</sub> (see Note 3)	
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

- 2. This current flows only when the output is in the high state and  $V_O > V_{CC}$ .
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.



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#### recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
VCC	Supply voltage		2.7	3.6	V
VIH	High-level input voltage		2		V
VIL	Low-level input voltage			0.8	V
VI	Input voltage			5.5	V
IOH	High-level output current			-32	mA
IOL	Low-level output current			64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10	ns/V
Δt/ΔV <sub>CC</sub>	Power-up ramp rate		200		μs/V
Т <sub>А</sub>	Operating free-air temperature		-40	85	°C

NOTE 4: All unused control inputs of the device must be held at VCC or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAF	RAMETER	TEST CONDITIC	ONS	MIN TY	PT MAX	UNIT	
VIK		V <sub>CC</sub> = 2.7 V,	l <sub>l</sub> = –18 mA		-1.2	V	
		$V_{CC} = 2.7 V \text{ to } 3.6 V,$	I <sub>OH</sub> = −100 μA	V <sub>CC</sub> -0.2			
∨он		V <sub>CC</sub> = 2.7 V,	IOH = -8 mA	2.4		V	
		V <sub>CC</sub> = 3 V,	I <sub>OH</sub> = -32 mA	2			
		$V_{CC} = 2.7 V$			0.2		
		V <sub>CC</sub> = 2.7 V	I <sub>OL</sub> = 24 mA		0.5		
VOL			I <sub>OL</sub> = 16 mA		0.4	V	
		$V_{CC} = 3 V$	I <sub>OL</sub> = 32 mA		0.5		
			I <sub>OL</sub> = 64 mA		0.55		
	Quarteral liserante	V <sub>CC</sub> = 3.6 V,	$V_I = V_{CC} \text{ or } GND$		±1		
	Control inputs	V <sub>CC</sub> = 0 or 3.6 V,	V <sub>I</sub> = 5.5 V		10		
lj			V <sub>I</sub> = 5.5 V		20	μA	
	A or B ports‡	V <sub>CC</sub> = 3.6 V	$V_I = V_{CC}$		1		
			$V_{I} = 0$	-5			
loff		$V_{CC} = 0,$	$V_{I}$ or $V_{O}$ = 0 to 4.5 V		±100	μΑ	
		N 2N	V <sub>I</sub> = 0.8 V	75			
ll(hold)	A or B ports	V <sub>CC</sub> = 3 V	V <sub>I</sub> = 2 V -75			μA	
. ,		V <sub>CC</sub> = 3.6 V§,	V <sub>I</sub> = 0 to 3.6 V		±500		
IOZPU		$V_{CC} = 0$ to 1.5 V, $V_O = 0.5$ V to 3 V, $\overline{OE}/OE$	= don't care		±100	μA	
IOZPD		$V_{CC} = 1.5$ V to 0, $V_{O} = 0.5$ V to 3 V, $\overline{OE}/OE$	= don't care		±100	μA	
			Outputs high		0.19		
ICC		$V_{CC} = 3.6 \text{ V}, I_{O} = 0, V_{I} = V_{CC} \text{ or GND}$	Outputs low		5	mA	
•••			Outputs disabled		0.19	1	
∆ICC		$V_{CC}$ = 3 V to 3.6 V, One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND			0.2	mA	
Ci		V <sub>I</sub> = 3 V or 0		1	4	pF	
Cio		$V_{O} = 3 V \text{ or } 0$			10	pF	

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C. <sup>‡</sup> Unused pins at V<sub>CC</sub> or GND

§ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another. This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.



## **SN74LVTH16500-EP 3.3-V ABT 18-BIT UNIVERSAL BUS TRANSCEIVER** WITH 3-STATE OUTPUTS SCBS783 – NOVEMBER 2003

#### timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

				۷ <sub>CC</sub> = ± 0.3		V <sub>CC</sub> =	2.7 V	UNIT
				MIN	MAX	MIN	MAX	
fclock	Clock frequency				150		150	MHz
	Date describer	LE high		3.3		3.3		
tw	Pulse duration	CLK high or low				3.3		ns
		A before CLKAB↓		2.9		2.9		
		B before CLKBA↓		2.9		2.9		
<sup>t</sup> su	Setup time			1.4		0.5		ns
		A or B before LE $\downarrow$	CLK low	2.9		2.3		
	Held See	A or B after CLK↓		0.4		0.4		
th	Hold time A or B after L			1.6		1.6		ns

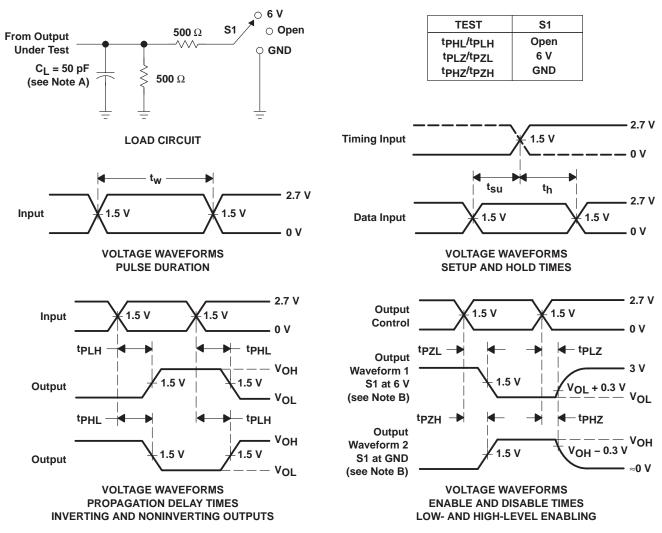
## switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO		CC = 3.3 ± 0.3 V	V	V <sub>CC</sub> = 2.7 V		UNIT	
	(INPUT)	(OUTPUT)	MIN	TYP†	MAX	MIN	MAX		
f <sub>max</sub>			150			150		MHz	
<sup>t</sup> PLH	B or A	A or B	1.3	2.8	3.7		4		
<sup>t</sup> PHL	B OF A	A OF B	1.3	2.6	3.7		4	ns	
<sup>t</sup> PLH	LEBA or LEAB	A at D	1.5	3.8	5.1		5.7		
<sup>t</sup> PHL	LEBA OF LEAD	A or B	1.5	3.8	5.1		5.7	ns	
<sup>t</sup> PLH	CLKBA or CLKAB	A at D	1.3	3.6	5		5.9		
<sup>t</sup> PHL	CLKBA OF CLKAB	A or B	1.3	3.5	5		5.9	ns	
<sup>t</sup> PZH		A	1.3	3.6	4.8		5.5		
<sup>t</sup> PZL	OEBA or OEAB	A or B	1.3	3.6	4.8		5.5	ns	
<sup>t</sup> PHZ	OEBA or OEAB	A or B	1.7	4.5	5.8		6.3		
<sup>t</sup> PLZ	OEDA UI OEAD	AUD	1.7	4.1	5.8		6.3	ns	

 $\overline{\dagger}$  All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.



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#### PARAMETER MEASUREMENT INFORMATION

NOTES: A. Cl includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms



#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins F	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
CLVTH16500IDGGREP	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
V62/04713-01XE	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

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<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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• Catalog: SN74LVTH16500

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

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#### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CLVTH16500IDGGREP	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1



## PACKAGE MATERIALS INFORMATION

5-Aug-2008



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CLVTH16500IDGGREP	TSSOP	DGG	56	2000	346.0	346.0	41.0

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